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Supporting Information

Efficient reduction of Graphene Oxide to Graphene Nanosheets by Silica based Ionic Liquid: Synthesis, Characterization and Catalytic properties of IMD-Si/FeCl₄-@GNS

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General experimental details

All solvents and chemicals used were purchased from Merck. Melting points of all synthesized compounds were taken in a Riechert Thermover instrument and are uncorrected. The IR spectra (KBr) were recorded on PerkinElmer RXI spectrometer. 1H NMR and 13C NMR spectra were recorded on a Bruker DRX-400 and Bruker Avance II 500 spectrometer using tetramethylsilane (TMS) as an internal standard and DMSOd6/CDCl3 as solvent. Mass spectra were recorded on Micromass Quattro II electrospray ionization (ESI) spectrometer. Elemental analyses (C, H and N) were conducted using the Elemental vario EL III elemental analyser. TGA data were obtained with a DSC-60 Shimadzu instrument. TGA were performed in the temperature range 0–600 °C at a constant heating rate of 20 °C min⁻¹ in a nitrogen atmosphere. X-ray diffractograms (XRD) of the catalyst were recorded in the 2θ range of 5–90° with a scan rate of 8°/min on a Rigaku Minifax X-ray diffractometer with Ni-filtered Cu Ka radiation at a wavelength of 1.54060 Å. SEM-EDX characterization of the catalyst was performed on a JEOL JSM-6510 scanning electron microscope equipped with an energy-dispersive X-ray spectrometer operating at 20 kV. TEM analysis was performed on JEM-2100 F Model (ACC. Voltage: 200 kV) electron microscope. XPS was performed on PHI 5000 VersaProbe III instrument.



Figure S1. UV -Vis spectrum of (a) GO and (b) IMD-Si/FeCl₄-@GNS



Figure S2. TG curves of (a) GO (b) IMD-Si/FeCl₄ @GNS and (c) Recycled catalyst



Figure S3. EPR spectrum of IMD-Si/FeCl₄-@GNS catalyst



Figure S4: Effect of amount of material on model reaction^a (*aReaction conditions*: acetyl 1,3dimethylbarbituric acid **1c** (2 mmol), thiosemicarbazide **2** (2 mmol), IMD-Si/FeCl₄⁻@GNS, T = 30° C. ^bReaction progress monitored by TLC. ^cIsolated yield)



Figure S5: (a) SEM and (b) TEM images of recycled catalyst after five runs

Spectral data of newly synthesized compounds





Anal. Found (C₁₀H₉N₃): C, 54.42; H, 4.17; N, 21.45, ESI-MS *m/z*:

NO₂

 $396.19 (M^+ + 1).$

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